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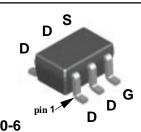
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FDG313N Digital FET, N-Channel General Description

This N-Channel enhancement mode field effect transistor is produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. This device has been designed especially for low voltage applications as a replacement for bipolar digital transistor and small signal MOSFET.

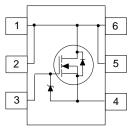
Applications

- Load switch
- Battery protection
- Power management



Features

- 0.95 A, 25 V. $R_{DS(on)} = 0.45 \ \Omega \ @ V_{GS} = 4.5 \ V$ $R_{DS(on)} = 0.60 \ \Omega \ @ V_{GS} = 2.7 \ V.$
- Low gate charge (1.64 nC typical)
- Very low level gate drive requirements allowing direct operation in 3V circuits (V_{GS(th)} < 1.5V).
- Gate-Source Zener for ESD ruggedness (>6kV Human Body Model).
- Compact industry standard SC70-6 surface mount package.



SC70-6

Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter Drain-Source Voltage		FDG313N	Units V	
V _{DSS}			25		
V _{GSS}	Gate-Source Voltage		<u>+</u> 8	V	
I _D	Drain Current - Continuous	(Note 1a)	0.95	A	
	- Pulsed		2		
P _D	Power Dissipation for Single Operation	(Note 1a)	0.75	W	
		(Note 1b)	0.55		
		(Note 1c)	0.48		
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to +150	۰C	
ESD	Electrostatic Discharge Rating MIL-STD-883 Human Body Model (100pf / 1500 Ohm)	BD	6	kV	

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$R_{\theta^{JA}}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	260	

Package Outlines and Ordering Information

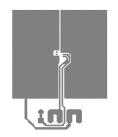
Device Marking	Device	Reel Size	Tape Width	Quantity
.13	FDG313N	7"	8mm	3000 units

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°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		1			
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	25			V
<u>ABVdss</u> ATJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		30		mV/∘C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
I _{GSS}	Gate-Body Leakage Current	$V_{GS} = 8 V, V_{DS} = 0 V$			100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.65	0.8	1.5	V
<u>ΔVGS(th)</u> ΔTJ	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		-2		mV/∘C
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 V, I_D = 0.5 A$ $V_{GS} = 4.5 V, I_D = 0.5 A @ 125 \circ C$ $V_{GS} = 2.7 V, I_D = 0.2 A$		0.35 0.53 0.45	0.45 0.76 0.6	Ω
I _{D(on)}	On-State Drain Current	$V_{GS}=4.5~V,~V_{DS}=5~V$	0.5			А
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}$		1.5		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		50		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		28		pF
C _{rss}	Reverse Transfer Capacitance			9		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{\text{DD}} = 6 \text{ V}, \text{ I}_{\text{D}} = 0.5 \text{ A},$ $V_{\text{GS}} = 4.5 \text{ V}, \text{ R}_{\text{GEN}} = 50 \Omega$		3	6	ns
t _r	Turn-On Rise Time			8.5	18	ns
t _{d(off)}	Turn-Off Delay Time			17	30	ns
t _f	Turn-Off Fall Time			13	25	ns
Qg	Total Gate Charge	$V_{DS} = 5 V, I_D = 0.95 A, V_{GS} = 4.5 V$		1.64	2.3	nC
Q _{gs}	Gate-Source Charge			0.38		nC
Q _{gd}	Gate-Drain Charge]		0.45		nC
Drain-Sc	ource Diode Characteristics an	d Maximum Ratings				
l _s	Maximum Continuous Drain-Source D	-			0.6	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 0.6 A$ (Note 2)		0.8	1.2	V

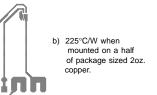
1. $R_{\theta,JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,JA}$ is determined by the user's board design.



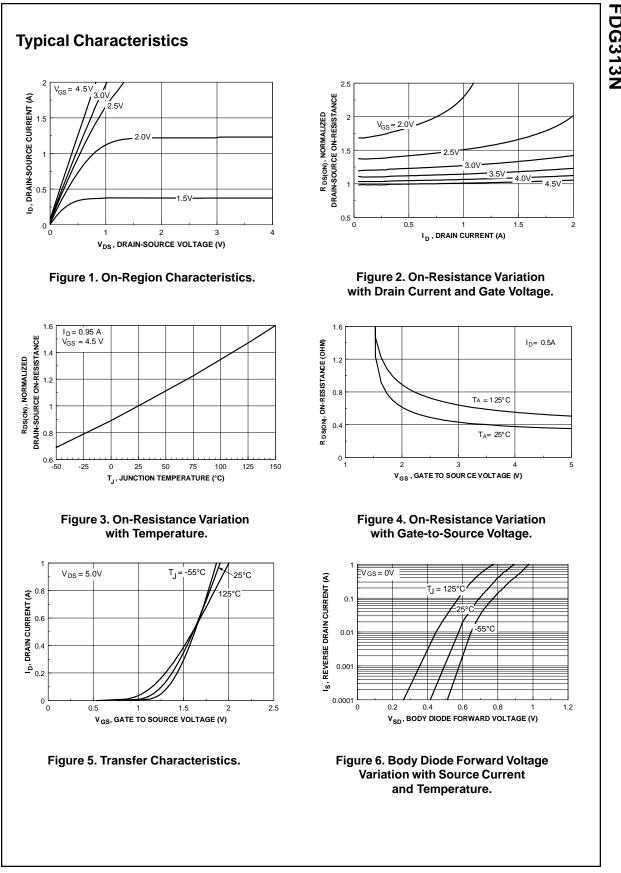
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300~\mu s,~\text{Duty}~\text{Cycle} \leq 2.0\%$

 a) 170°C/W when mounted on a 1 in² pad of 2oz copper.

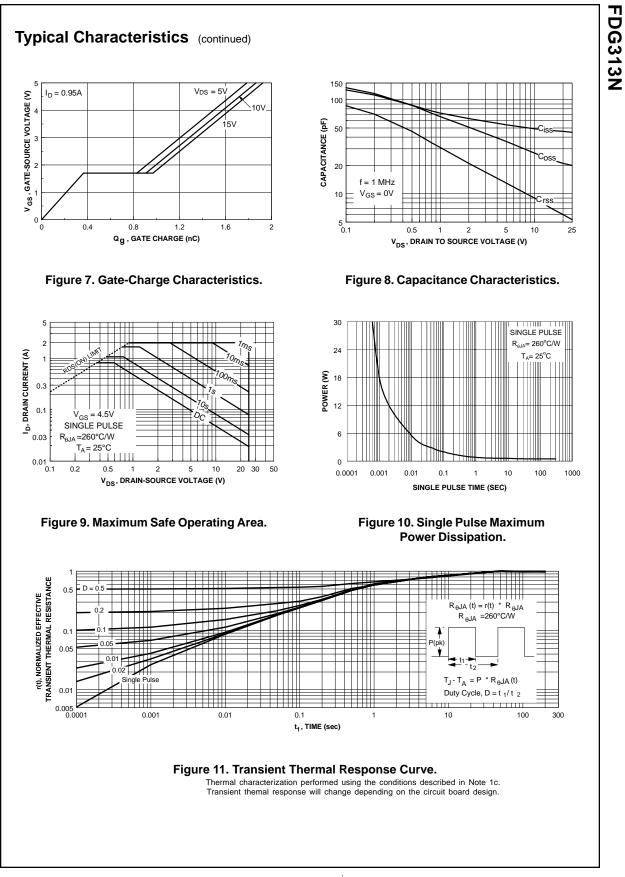


c) 260°C/W when mounted on a minimum pad of 2oz copper. FDG313N



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FDG313N



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